

TYPES SN54H103, SN74H103 DUAL J-K NEGATIVE-EDGE-TRIGGERED FLIP-FLOPS WITH CLEAR

REVISED DECEMBER 1983

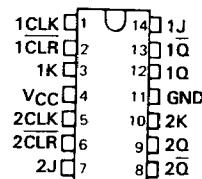
- Package Options Include Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

description

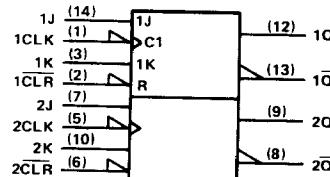
These dual monolithic J-K flip-flops are negative-edge-triggered. They feature individual J, K, clock, and asynchronous clear inputs to each flip-flop. When the clock goes high, the inputs are enabled and data will be accepted. Logical state of J and K inputs may be allowed to change when the clock pulse is in a high state and bistable will perform according to the truth table as long minimum set-up times are observed. Input data is transferred to the outputs on the negative edge of the clock pulse.

The SN54H103 is characterized for operation over the full military temperature range of -55°C to 125°C . The SN74H103 is characterized for operation from 0° to 70°C .

**SN54H103 . . . J OR W PACKAGE
SN74H103 . . . J OR N PACKAGE**
(TOP VIEW)



logic symbol



Pin numbers shown are for J and N packages.

FUNCTION TABLE

INPUTS				OUTPUTS	
CLR	CLK	J	K	Q	\Q
L	X	X	X	L	H
H	↓	L	L	Q _O	\Q _O
H	↓	H	L	H	L
H	↓	L	H	L	H
H	↓	H	H	TOGGLE	
H	H	X	X	Q _O	\Q _O

3

TTL DEVICES

PRODUCTION DATA

This document contains information current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

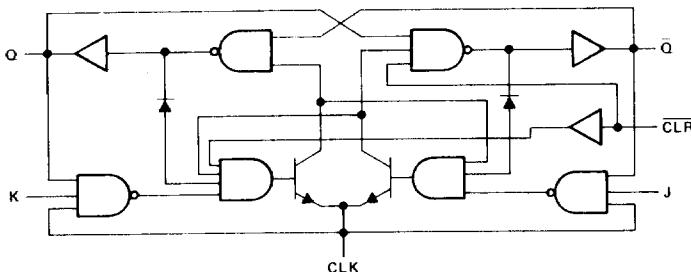
3-416

**TEXAS
INSTRUMENTS**

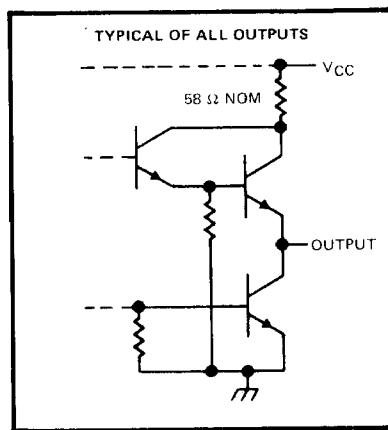
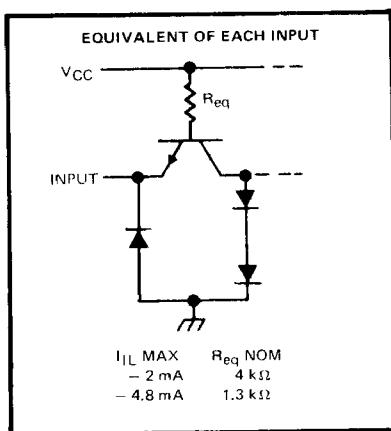
POST OFFICE BOX 225012 • DALLAS, TEXAS 75265

**TYPES SN54H103, SN74H103
DUAL J-K NEGATIVE-EDGE-TRIGGERED
FLIP-FLOPS WITH CLEAR**

logic diagram



schematics of inputs and outputs



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

NOTE 1: Voltage values are with respect to network ground terminal.

3

TTL DEVICES

**TYPES SN54H103, SN74H103
DUAL J-K NEGATIVE-EDGE-TRIGGERED
FLIP-FLOPS WITH CLEAR**

recommended operating conditions

		SN54H103			SN74H103			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage				0.8		0.8	V
I_{OH}	Low-level output current				-0.5		-0.5	μA
I_{OL}	Low-level output current				20		20	mA
t_w	Pulse duration	CLK high	10		10			ns
		CLK low	15		15			
		CLR low	16		16			
t_{SU}	Setup time before CLK ↓	High-level data	10		10			ns
		Low-level data	13		13			
t_h	Hold time-data after CLK ↓		0		0			ns
T_A	Operating free-air temperature	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS [†]		SN54H103			SN74H103			UNIT
			MIN	TYP [‡]	MAX	MIN	TYP [‡]	MAX	
V_{IK}	$V_{CC} = \text{MIN}$, $I_I = -8 \text{ mA}$					-1.5		-1.5	V
V_{OH}	$V_{CC} = \text{MIN}$, $V_{IH} = 2 \text{ V}$, $V_{IL} = 0.8 \text{ V}$, $I_{OH} = -0.5 \text{ mA}$		2.4	3.4		2.4	3.4		V
V_{OL}	$V_{CC} = \text{MIN}$, $V_{IH} = 2 \text{ V}$, $V_{IL} = 0.8 \text{ V}$, $I_{OL} = 20 \text{ mA}$			0.2	0.4		0.2	0.4	V
I_I	$V_{CC} = \text{MAX}$, $V_I = 5.5 \text{ V}$					1		1	mA
IIH	$V_{CC} = \text{MAX}$, $V_I = 2.4 \text{ V}$			50		50		50	μA
				100		100		100	
			0	-1		0	-1	-1	mA
IIL	$V_{CC} = \text{MAX}$, $V_I = 0.4 \text{ V}$			-1	-2	-1	-2	-2	
				-1	-2	-1	-2	-2	mA
				-3	-4.8	-3	-4.8	-4.8	
I_{OS} [§]	$V_{CC} = \text{MAX}$		-40		-100	-40		-100	mA
I_{CC}	$V_{CC} = \text{MAX}$, See Note 2		20	38		20	38		mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$.

[§] Not more than one output should be shorted at a time, and duration of short-circuit should not exceed one second.

NOTE 2: With all outputs open, I_{CC} is measured with the Q and \bar{Q} outputs high in turn. At the time of measurement, the clock input is grounded.

3

TTL DEVICES

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$ (see note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS			MIN	TYP	MAX	UNIT
f_{max}						40	50		MHz
t_{PLH}	CLR	Q or \bar{Q}				8	12		ns
t_{PHL}	\bar{CLR} (CLK high) \bar{CLR} (CLK low)	\bar{Q} or Q	$R_L = 280 \Omega$, $C_L = 25 \text{ pF}$			15	20		
						23	35		ns
t_{PLH} t_{PHL}	CLK	Q or \bar{Q}				10	15		
						16	20		ns

NOTE 3: See General Information Section for load circuits and voltage waveforms.